

**Search Notes**

Application/Control No.

09/269,518

Examiner

Devin Hanan

Applicant(s)/Patent under  
Reexamination

FENNER ET AL.

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
415	211.2		
416	185,186R		
	188, DIG5		
	186A		
415	218.1		
	219.1	3/9/2005	DH
417	423.1		
	366	3/15/2005	DH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted Chris Verdier on class 416, 415	3/9/2005	DH
consulted Chuck Freay on class 417	3/15/2005	DH